

# 4-Mbit (256 K × 18) Pipelined DCD Sync SRAM

## Features

- Registered inputs and outputs for pipelined operation
- Optimal for performance (double-cycle deselect)
  - Depth expansion without wait state
- 256 K × 18 common I/O architecture
- 3.3 V core power supply ( $V_{DD}$ )
- 3.3 V/2.5 V I/O power supply ( $V_{DDQ}$ )
- Fast clock-to-output times
  - 4.0 ns (for 133-MHz device)
- Provide high-performance 3-1-1-1 access rate
- User-selectable burst counter supporting Intel® Pentium® interleaved or linear burst sequences
- Separate processor and controller address strobes
- Synchronous self-timed writes
- Asynchronous output enable
- Available in Pb-free 100-pin TQFP package
- “ZZ” sleep mode option

## Functional Description

The CY7C1328G SRAM integrates 256 K × 18 SRAM cells with advanced synchronous peripheral circuitry and a two-bit counter for internal burst operation. All synchronous inputs are gated by registers controlled by a positive-edge-triggered clock input (CLK). The synchronous inputs include all addresses, all data inputs, address-pipelining chip enable ( $\overline{CE}_1$ ), depth-expansion chip enables ( $\overline{CE}_2$  and  $\overline{CE}_3$ ), burst control inputs (ADSC, ADSP, and ADV), write enables ( $BW_{[A:B]}$ , and BWE), and global write (GW). Asynchronous inputs include the output enable ( $\overline{OE}$ ) and the ZZ pin.

Addresses and chip enables are registered at rising edge of clock when either address strobe processor (ADSP) or address strobe controller (ADSC) are active. Subsequent burst addresses can be internally generated as controlled by the advance pin (ADV).

Address, data inputs, and write controls are registered on-chip to initiate a self-timed write cycle. This part supports byte write operations (see [Pin Definitions on page 5](#) and [Truth Table on page 8](#) for further details). Write cycles can be one to two bytes wide as controlled by the byte write control inputs. GW active LOW causes all bytes to be written. This device incorporates an additional pipelined enable register which delays turning off the output buffers an additional cycle when a deselect is executed. This feature allows depth expansion without penalizing system performance.

The CY7C1328G operates from a +3.3 V core power supply while all outputs operate with a +3.3 V or a +2.5 V supply. All inputs and outputs are JEDEC-standard JESD8-5-compatible.

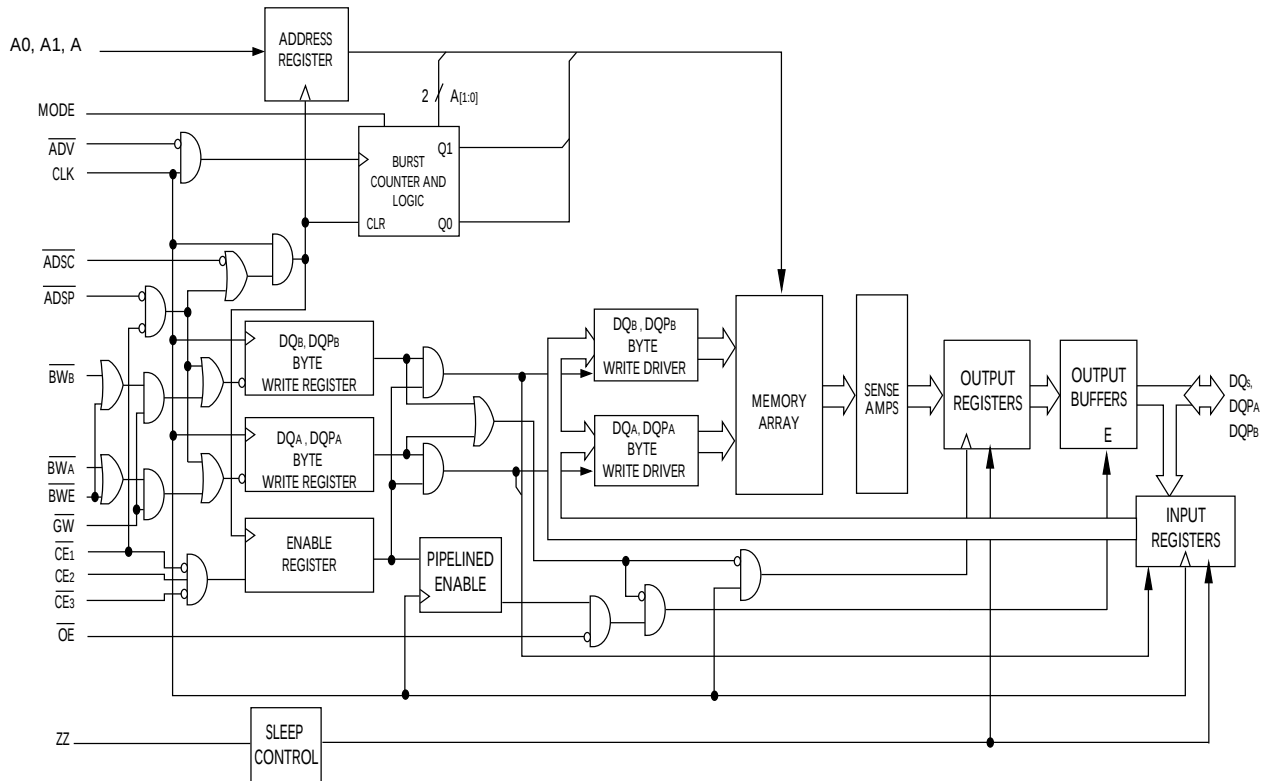
For a complete list of related documentation, click [here](#).

## Selection Guide

| Description                  | 133 MHz | Unit |
|------------------------------|---------|------|
| Maximum access time          | 4.0     | ns   |
| Maximum operating current    | 225     | mA   |
| Maximum CMOS standby current | 40      | mA   |

**Errata:** For information on silicon errata, see [Errata on page 20](#). Details include trigger conditions, devices affected, and proposed workaround.

## Logic Block Diagram



## Contents

|                                               |           |                                                      |           |
|-----------------------------------------------|-----------|------------------------------------------------------|-----------|
| <b>Pin Configurations</b> .....               | <b>4</b>  | <b>Switching Characteristics</b> .....               | <b>12</b> |
| <b>Pin Definitions</b> .....                  | <b>5</b>  | <b>Switching Waveforms</b> .....                     | <b>13</b> |
| <b>Functional Overview</b> .....              | <b>6</b>  | <b>Ordering Information</b> .....                    | <b>17</b> |
| Single Read Accesses .....                    | 6         | Ordering Code Definitions .....                      | 17        |
| Single Write Accesses Initiated by ADSP ..... | 6         | <b>Package Diagram</b> .....                         | <b>18</b> |
| Single Write Accesses Initiated by ADSC ..... | 7         | <b>Acronyms</b> .....                                | <b>19</b> |
| Burst Sequences .....                         | 7         | <b>Document Conventions</b> .....                    | <b>19</b> |
| Sleep Mode .....                              | 7         | Units of Measure .....                               | 19        |
| Interleaved Burst Address Table .....         | 7         | <b>Errata</b> .....                                  | <b>20</b> |
| Linear Burst Address Table .....              | 7         | Part Numbers Affected .....                          | 20        |
| ZZ Mode Electrical Characteristics .....      | 7         | Product Status .....                                 | 20        |
| <b>Truth Table</b> .....                      | <b>8</b>  | Ram9 Sync ZZ Pin Issues Errata Summary .....         | 20        |
| <b>Truth Table for Read/Write</b> .....       | <b>9</b>  | <b>Document History Page</b> .....                   | <b>21</b> |
| <b>Maximum Ratings</b> .....                  | <b>10</b> | <b>Sales, Solutions, and Legal Information</b> ..... | <b>23</b> |
| <b>Operating Range</b> .....                  | <b>10</b> | Worldwide Sales and Design Support .....             | 23        |
| <b>Electrical Characteristics</b> .....       | <b>10</b> | Products .....                                       | 23        |
| <b>Capacitance</b> .....                      | <b>11</b> | PSoC® Solutions .....                                | 23        |
| <b>Thermal Resistance</b> .....               | <b>11</b> | Cypress Developer Community .....                    | 23        |
| <b>AC Test Loads and Waveforms</b> .....      | <b>11</b> | Technical Support .....                              | 23        |

**Figure 1. 100-pin TQFP (14 × 20 × 1.4 mm) pinout <sup>[1]</sup>**

## Pin Definitions

| Pin                                   | TQFP                                                                    | Type               | Description                                                                                                                                                                                                                                                                                                                                                           |
|---------------------------------------|-------------------------------------------------------------------------|--------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| A <sub>0</sub> , A <sub>1</sub> , A   | 37, 36, 32, 33, 34, 35, 44, 45, 46, 47, 48, 49, 50, 80, 81, 82, 99, 100 | Input-synchronous  | <b>Address inputs used to select one of the 256 K address locations.</b> Sampled at the rising edge of the CLK if ADSP or ADSC is active LOW, and $\overline{CE}_1$ , $\overline{CE}_2$ , and $\overline{CE}_3$ are sampled active. A <sub>[1:0]</sub> are fed to the two-bit counter.                                                                                |
| $\overline{BW}_A$ , $\overline{BW}_B$ | 93, 94                                                                  | Input-synchronous  | <b>Byte write select inputs, active LOW.</b> Qualified with $\overline{BWE}$ to conduct byte writes to the SRAM. Sampled on the rising edge of CLK.                                                                                                                                                                                                                   |
| $\overline{GW}$                       | 88                                                                      | Input-synchronous  | <b>Global write enable input, active LOW.</b> When asserted LOW on the rising edge of CLK, a global write is conducted (all bytes are written, regardless of the values on $\overline{BW}_{[A:B]}$ and $\overline{BWE}$ ).                                                                                                                                            |
| $\overline{BWE}$                      | 87                                                                      | Input-synchronous  | <b>Byte write enable input, active LOW.</b> Sampled on the rising edge of CLK. This signal must be asserted LOW to conduct a byte write.                                                                                                                                                                                                                              |
| CLK                                   | 89                                                                      | Input-clock        | <b>Clock input.</b> Used to capture all synchronous inputs to the device. Also used to increment the burst counter when ADV is asserted LOW, during a burst operation.                                                                                                                                                                                                |
| $\overline{CE}_1$                     | 98                                                                      | Input-synchronous  | <b>Chip enable 1 input, active LOW.</b> Sampled on the rising edge of CLK. Used in conjunction with $\overline{CE}_2$ and $\overline{CE}_3$ to select/deselect the device. ADSP is ignored if $\overline{CE}_1$ is HIGH. $\overline{CE}_1$ is sampled only when a new external address is loaded.                                                                     |
| $\overline{CE}_2$                     | 97                                                                      | Input-synchronous  | <b>Chip enable 2 input, active HIGH.</b> Sampled on the rising edge of CLK. Used in conjunction with $\overline{CE}_1$ and $\overline{CE}_3$ to select/deselect the device. $\overline{CE}_2$ is sampled only when a new external address is loaded.                                                                                                                  |
| $\overline{CE}_3$                     | 92                                                                      | Input-synchronous  | <b>Chip enable 3 input, active LOW.</b> Sampled on the rising edge of CLK. Used in conjunction with $\overline{CE}_1$ and $\overline{CE}_2$ to select/deselect the device. $\overline{CE}_3$ is sampled only when a new external address is loaded.                                                                                                                   |
| $\overline{OE}$                       | 86                                                                      | Input-asynchronous | <b>Output enable, asynchronous input, active LOW.</b> Controls the direction of the I/O pins. When LOW, the I/O pins behave as outputs. When deasserted HIGH, DQ pins are tri-stated, and act as input data pins. $\overline{OE}$ is masked during the first clock of a read cycle when emerging from a deselected state.                                             |
| ADV                                   | 83                                                                      | Input-synchronous  | <b>Advance input signal, sampled on the rising edge of CLK, active LOW.</b> When asserted, it automatically increments the address in a burst cycle.                                                                                                                                                                                                                  |
| ADSP                                  | 84                                                                      | Input-synchronous  | <b>Address strobe from processor, sampled on the rising edge of CLK, active LOW.</b> When asserted LOW, addresses presented to the device are captured in the address registers. A <sub>[1:0]</sub> are also loaded into the burst counter. When ADSP and ADSC are both asserted, only ADSP is recognized. ADSP is ignored when $\overline{CE}_1$ is deasserted HIGH. |
| ADSC                                  | 85                                                                      | Input-synchronous  | <b>Address strobe from controller, sampled on the rising edge of CLK, active LOW.</b> When asserted LOW, addresses presented to the device are captured in the address registers. A <sub>[1:0]</sub> are also loaded into the burst counter. When ADSP and ADSC are both asserted, only ADSP is recognized.                                                           |
| ZZ <sup>[2]</sup>                     | 64                                                                      | Input-asynchronous | <b>ZZ “sleep” input, active HIGH.</b> When asserted HIGH places the device in a non-time-critical “sleep” condition with data integrity preserved. During normal operation, this pin has to be low or left floating. ZZ pin has an internal pull-down.                                                                                                                |

### Note

- Errata:** The ZZ pin (Pin 64) needs to be externally connected to ground. For more information, see [Errata on page 20](#).

## Pin Definitions *(continued)*

| Pin                          | TQFP                                                                                                                | Type                | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
|------------------------------|---------------------------------------------------------------------------------------------------------------------|---------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| DQs,<br>DQP <sub>[A:B]</sub> | 58, 59, 62, 63,<br>68, 69, 72, 73,<br>74, 8, 9, 12,<br>13, 18, 19, 22,<br>23, 24                                    | I/O-<br>synchronous | <b>Bidirectional data I/O lines.</b> As inputs, they feed into an on-chip data register that is triggered by the rising edge of CLK. As outputs, they deliver the data contained in the memory location specified by the addresses presented during the previous clock rise of the read cycle. The direction of the pins is controlled by OE. When OE is asserted LOW, the pins behave as outputs. When HIGH, DQs and DQP <sub>[A:B]</sub> are placed in a tristate condition. |
| V <sub>DD</sub>              | 15, 41, 65, 91                                                                                                      | Power supply        | <b>Power supply inputs to the core of the device.</b>                                                                                                                                                                                                                                                                                                                                                                                                                          |
| V <sub>SS</sub>              | 17, 40, 67, 90                                                                                                      | Ground              | <b>Ground for the core of the device.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| V <sub>DDQ</sub>             | 4, 11, 20, 27,<br>54, 61, 70, 77                                                                                    | I/O power<br>supply | <b>Power supply for the I/O circuitry.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| V <sub>SSQ</sub>             | 5, 10, 21, 26,<br>55, 60, 71, 76                                                                                    | I/O ground          | <b>Ground for the I/O circuitry.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| MODE                         | 31                                                                                                                  | Input-<br>static    | <b>Selects burst order.</b> When tied to GND selects linear burst sequence. When tied to V <sub>DD</sub> or left floating selects interleaved burst sequence. This is a strap pin and should remain static during device operation. Mode pin has an internal pull-up.                                                                                                                                                                                                          |
| NC                           | 1, 2, 3, 6, 7,<br>14, 16, 25, 28,<br>29, 30, 38, 39,<br>42, 43, 51, 52,<br>53, 56, 57, 66,<br>75, 78, 79, 95,<br>96 | —                   | <b>No connects.</b> Not internally connected to the die.                                                                                                                                                                                                                                                                                                                                                                                                                       |

## Functional Overview

All synchronous inputs pass through input registers controlled by the rising edge of the clock. All data outputs pass through output registers controlled by the rising edge of the clock.

The CY7C1328G supports secondary cache in systems utilizing either a linear or interleaved burst sequence. The interleaved burst order supports Pentium and i486™ processors. The linear burst sequence is suited for processors that utilize a linear burst sequence. The burst order is user selectable, and is determined by sampling the MODE input. Accesses can be initiated with either the processor address strobe (ADSP) or the controller address strobe (ADSC). Address advancement through the burst sequence is controlled by the ADV input. A two-bit on-chip wraparound burst counter captures the first address in a burst sequence and automatically increments the address for the rest of the burst access.

Byte write operations are qualified with the byte write enable (BWE) and byte write select (BW<sub>[A:B]</sub>) inputs. A global write enable (GW) overrides all byte write inputs and writes data to all four bytes. All writes are simplified with on-chip synchronous self-timed write circuitry.

Synchronous chip selects  $\overline{CE}_1$ , CE<sub>2</sub>,  $\overline{CE}_3$  and an asynchronous output enable ( $\overline{OE}$ ) provide for easy bank selection and output tristate control. ADSP is ignored if CE<sub>1</sub> is HIGH.

### Single Read Accesses

This access is initiated when the following conditions are satisfied at clock rise: (1) ADSP or ADSC is asserted LOW, (2) chip selects are all asserted active, and (3) the write signals (GW, BWE) are all deasserted HIGH. ADSP is ignored if CE<sub>1</sub> is HIGH. The address presented to the address inputs is stored into

the address advancement logic and the address register while being presented to the memory core. The corresponding data is allowed to propagate to the input of the output registers. At the rising edge of the next clock the data is allowed to propagate through the output register and onto the data bus within t<sub>CO</sub> if OE is active LOW. The only exception occurs when the SRAM is emerging from a deselected state to a selected state, its outputs are always tri-stated during the first cycle of the access. After the first cycle of the access, the outputs are controlled by the OE signal. Consecutive single read cycles are supported.

The CY7C1328G is a double-cycle deselect part. Once the SRAM is deselected at clock rise by the chip select and either ADSP or ADSC signals, its output will tristate immediately after the next clock rise.

### Single Write Accesses Initiated by ADSP

This access is initiated when both of the following conditions are satisfied at clock rise: (1) ADSP is asserted LOW, and (2) chip select is asserted active. The address presented is loaded into the address register and the address advancement logic while being delivered to the memory core. The write signals (GW, BWE, and BW<sub>[A:B]</sub>) and ADV inputs are ignored during this first cycle.

ADSP triggered write accesses require two clock cycles to complete. If GW is asserted LOW on the second clock rise, the data presented to the DQx inputs is written into the corresponding address location in the memory core. If GW is HIGH, then the write operation is controlled by BWE and BW<sub>[A:B]</sub> signals. The CY7C1328G provides byte write capability that is described in the Write Cycle Description table. Asserting the byte write enable input (BWE) with the selected byte write input will selectively write to only the desired bytes. Bytes not selected

during a byte write operation will remain unaltered. A synchronous self-timed write mechanism has been provided to simplify the write operations.

Because the CY7C1328G is a common I/O device, the output enable (OE) must be deasserted HIGH before presenting data to the DQ inputs. Doing so will tristate the output drivers. As a safety precaution, DQ are automatically tri-stated whenever a write cycle is detected, regardless of the state of OE.

### Single Write Accesses Initiated by $\overline{\text{ADSC}}$

$\overline{\text{ADSC}}$  write accesses are initiated when the following conditions are satisfied: (1)  $\overline{\text{ADSC}}$  is asserted LOW, (2)  $\overline{\text{ADSP}}$  is deasserted HIGH, (3) chip select is asserted active, and (4) the appropriate combination of the write inputs (GW, BWE, and  $\overline{\text{BW}}_{\text{[A:B]}}$ ) are asserted active to conduct a write to the desired byte(s).  $\overline{\text{ADSC}}$  triggered write accesses require a single clock cycle to complete. The address presented is loaded into the address register and the address advancement logic while being delivered to the memory core. The ADV input is ignored during this cycle. If a global write is conducted, the data presented to the DQ<sub>X</sub> is written into the corresponding address location in the memory core. If a byte write is conducted, only the selected bytes are written. Bytes not selected during a byte write operation will remain unaltered. A synchronous self-timed write mechanism has been provided to simplify the write operations.

Because the CY7C1328G is a common I/O device, the output enable (OE) must be deasserted HIGH before presenting data to the DQ<sub>X</sub> inputs. Doing so will tristate the output drivers. As a safety precaution, DQ<sub>X</sub> are automatically tri-stated whenever a write cycle is detected, regardless of the state of OE.

### Burst Sequences

The CY7C1328G provides a two-bit wraparound counter, fed by A<sub>[1:0]</sub>, that implements either an interleaved or linear burst sequence. The interleaved burst sequence is designed specifically to support Intel Pentium applications. The linear burst sequence is designed to support processors that follow a linear burst sequence. The burst sequence is user selectable through the MODE input. Both read and write burst operations are supported.

Asserting  $\overline{\text{ADV}}$  LOW at clock rise will automatically increment the burst counter to the next address in the burst sequence. Both read and write burst operations are supported.

### Sleep Mode

The ZZ input pin is an asynchronous input. Asserting ZZ places the SRAM in a power conservation "sleep" mode. Two clock cycles are required to enter into or exit from this "sleep" mode. While in this mode, data integrity is guaranteed. Accesses pending when entering the "sleep" mode are not considered valid nor is the completion of the operation guaranteed. The device must be deselected prior to entering the "sleep" mode. CEs,  $\overline{\text{ADSP}}$ , and  $\overline{\text{ADSC}}$  must remain inactive for the duration of  $t_{\text{ZZREC}}$  after the ZZ input returns LOW.

### Interleaved Burst Address Table

(MODE = Floating or V<sub>DD</sub>)

| First Address<br>A1:A0 | Second Address<br>A1:A0 | Third Address<br>A1:A0 | Fourth Address<br>A1:A0 |
|------------------------|-------------------------|------------------------|-------------------------|
| 00                     | 01                      | 10                     | 11                      |
| 01                     | 00                      | 11                     | 10                      |
| 10                     | 11                      | 00                     | 01                      |
| 11                     | 10                      | 01                     | 00                      |

### Linear Burst Address Table

(MODE = GND)

| First Address<br>A1:A0 | Second Address<br>A1:A0 | Third Address<br>A1:A0 | Fourth Address<br>A1:A0 |
|------------------------|-------------------------|------------------------|-------------------------|
| 00                     | 01                      | 10                     | 11                      |
| 01                     | 10                      | 11                     | 00                      |
| 10                     | 11                      | 00                     | 01                      |
| 11                     | 00                      | 01                     | 10                      |

### ZZ Mode Electrical Characteristics

| Parameter          | Description                        | Test Conditions                                | Min               | Max               | Unit |
|--------------------|------------------------------------|------------------------------------------------|-------------------|-------------------|------|
| I <sub>DDZZ</sub>  | Snooze mode standby current        | $\text{ZZ} \geq V_{\text{DD}} - 0.2 \text{ V}$ | —                 | 40                | mA   |
| t <sub>ZZS</sub>   | Device operation to ZZ             | $\text{ZZ} \geq V_{\text{DD}} - 0.2 \text{ V}$ | —                 | 2t <sub>CYC</sub> | ns   |
| t <sub>ZZREC</sub> | ZZ recovery time                   | $\text{ZZ} \leq 0.2 \text{ V}$                 | 2t <sub>CYC</sub> | —                 | ns   |
| t <sub>ZZI</sub>   | ZZ active to snooze current        | This parameter is sampled                      | —                 | 2t <sub>CYC</sub> | ns   |
| t <sub>RZZI</sub>  | ZZ inactive to exit snooze current | This parameter is sampled                      | 0                 | —                 | ns   |

## Truth Table

The Truth Table for part CY7C1328G is as follows. [3, 4, 5, 6, 7]

| Operation                    | Address Used | $\overline{CE}_1$ | $CE_2$ | $\overline{CE}_3$ | ZZ | $\overline{ADSP}$ | $\overline{ADSC}$ | $\overline{ADV}$ | $\overline{WRITE}$ | $\overline{OE}$ | CLK | DQ       |
|------------------------------|--------------|-------------------|--------|-------------------|----|-------------------|-------------------|------------------|--------------------|-----------------|-----|----------|
| Deselected cycle, power-down | None         | H                 | X      | X                 | L  | X                 | L                 | X                | X                  | X               | L-H | Tristate |
| Deselected cycle, power-down | None         | L                 | L      | X                 | L  | L                 | X                 | X                | X                  | X               | L-H | Tristate |
| Deselected cycle, power-down | None         | L                 | X      | H                 | L  | L                 | X                 | X                | X                  | X               | L-H | Tristate |
| Deselected cycle, power-down | None         | L                 | L      | X                 | L  | H                 | L                 | X                | X                  | X               | L-H | Tristate |
| Deselected cycle, power-down | None         | L                 | X      | H                 | L  | H                 | L                 | X                | X                  | X               | L-H | Tristate |
| ZZ mode, power-down          | None         | X                 | X      | X                 | H  | X                 | X                 | X                | X                  | X               | X   | Tristate |
| Read cycle, begin burst      | External     | L                 | H      | L                 | L  | L                 | X                 | X                | X                  | L               | L-H | Q        |
| Read cycle, begin burst      | External     | L                 | H      | L                 | L  | L                 | X                 | X                | X                  | H               | L-H | Tristate |
| Write cycle, begin burst     | External     | L                 | H      | L                 | L  | H                 | L                 | X                | L                  | X               | L-H | D        |
| Read cycle, begin burst      | External     | L                 | H      | L                 | L  | H                 | L                 | X                | H                  | L               | L-H | Q        |
| Read cycle, begin burst      | External     | L                 | H      | L                 | L  | H                 | L                 | X                | H                  | H               | L-H | Tristate |
| Read cycle, continue burst   | Next         | X                 | X      | X                 | L  | H                 | H                 | L                | H                  | L               | L-H | Q        |
| Read cycle, continue burst   | Next         | X                 | X      | X                 | L  | H                 | H                 | L                | H                  | H               | L-H | Tristate |
| Read cycle, continue burst   | Next         | H                 | X      | X                 | L  | X                 | H                 | L                | H                  | L               | L-H | Q        |
| Read cycle, continue burst   | Next         | H                 | X      | X                 | L  | X                 | H                 | L                | H                  | H               | L-H | Tristate |
| Write cycle, continue burst  | Next         | X                 | X      | X                 | L  | H                 | H                 | L                | L                  | X               | L-H | D        |
| Write cycle, continue burst  | Next         | H                 | X      | X                 | L  | X                 | H                 | L                | L                  | X               | L-H | D        |
| Read cycle, suspend burst    | Current      | X                 | X      | X                 | L  | H                 | H                 | H                | H                  | L               | L-H | Q        |
| Read cycle, suspend burst    | Current      | X                 | X      | X                 | L  | H                 | H                 | H                | H                  | H               | L-H | Tristate |
| Read cycle, suspend burst    | Current      | H                 | X      | X                 | L  | X                 | H                 | H                | H                  | L               | L-H | Q        |
| Read cycle, suspend burst    | Current      | H                 | X      | X                 | L  | X                 | H                 | H                | H                  | H               | L-H | Tristate |
| Write cycle, suspend burst   | Current      | X                 | X      | X                 | L  | H                 | H                 | H                | L                  | X               | L-H | D        |
| Write cycle, suspend burst   | Current      | H                 | X      | X                 | L  | X                 | H                 | H                | L                  | X               | L-H | D        |

### Notes

- X = "Don't Care." H = Logic HIGH, L = Logic LOW.
- $\overline{WRITE}$  = L when any one or more byte write enable signals ( $\overline{BW}_A$ ,  $\overline{BW}_B$ ) and  $\overline{BWE}$  = L or  $\overline{GW}$  = L.  $\overline{WRITE}$  = H when all byte write enable signals ( $\overline{BW}_A$ ,  $\overline{BW}_B$ ),  $\overline{BWE}$ ,  $\overline{GW}$  = H.
- The DQ pins are controlled by the current cycle and the  $\overline{OE}$  signal.  $\overline{OE}$  is asynchronous and is not sampled with the clock.
- The  $\overline{SRAM}$  always initiates a read cycle when  $\overline{ADSP}$  is asserted, regardless of the state of  $\overline{GW}$ ,  $\overline{BWE}$ , or  $\overline{BW}_X$ . Writes may occur only on subsequent clocks after the  $\overline{ADSP}$  or with the assertion of  $\overline{ADSC}$ . As a result,  $\overline{OE}$  must be driven HIGH prior to the start of the write cycle to allow the outputs to tristate.  $\overline{OE}$  is a don't care for the remainder of the write cycle.
- $\overline{OE}$  is asynchronous and is not sampled with the clock rise. It is masked internally during write cycles. During a read cycle all data bits are tristate when  $\overline{OE}$  is inactive or when the device is deselected, and all data bits behave as output when  $\overline{OE}$  is active (LOW).

## Truth Table for Read/Write

The Truth Table for read or write for part CY7C1328G is as follows. <sup>[8]</sup>

| Function                                               | $\overline{GW}$ | $\overline{BWE}$ | $\overline{BW}_A$ | $\overline{BW}_B$ |
|--------------------------------------------------------|-----------------|------------------|-------------------|-------------------|
| Read                                                   | H               | H                | X                 | X                 |
| Read                                                   | H               | L                | H                 | H                 |
| Write byte A – (DQ <sub>A</sub> and DQP <sub>A</sub> ) | H               | L                | L                 | H                 |
| Write byte B – (DQ <sub>B</sub> and DQP <sub>B</sub> ) | H               | L                | H                 | L                 |
| Write all bytes                                        | H               | L                | L                 | L                 |
| Write all bytes                                        | L               | X                | X                 | X                 |

### Note

8. X = "Don't Care." H = Logic HIGH, L = Logic LOW.

## Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage temperature ..... -65 °C to +150 °C

Ambient temperature with power applied ..... -55 °C to +125 °C

Supply voltage on  $V_{DD}$  relative to GND ..... -0.5 V to +4.6 V

Supply voltage on  $V_{DDQ}$  relative to GND ..... -0.5 V to + $V_{DD}$

DC voltage applied to outputs in tristate ..... -0.5 V to  $V_{DDQ} + 0.5 V$

DC input voltage ..... -0.5 V to  $V_{DD} + 0.5 V$

Current into outputs (LOW) ..... 20 mA

Static discharge voltage (per MIL-STD-883, method 3015) ..... > 2001 V

Latch up current ..... > 200 mA

## Operating Range

| Range      | Ambient Temperature ( $T_A$ ) | $V_{DD}$           | $V_{DDQ}$              |
|------------|-------------------------------|--------------------|------------------------|
| Industrial | -40 °C to +85 °C              | 3.3 V - 5% / + 10% | 2.5 V - 5% to $V_{DD}$ |

## Electrical Characteristics

Over the Operating Range

| Parameter <sup>[9, 10]</sup> | Description                                   | Test Conditions                                                                                                             | Min   | Max              | Unit    |
|------------------------------|-----------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|-------|------------------|---------|
| $V_{DD}$                     | Power supply voltage                          |                                                                                                                             | 3.135 | 3.6              | V       |
| $V_{DDQ}$                    | I/O supply voltage                            |                                                                                                                             | 2.375 | $V_{DD}$         | V       |
| $V_{OH}$                     | Output HIGH voltage                           | $V_{DDQ} = 3.3 V, V_{DD} = \text{Min}, I_{OH} = -4.0 \text{ mA}$                                                            | 2.4   | —                | V       |
|                              |                                               | $V_{DDQ} = 2.5 V, V_{DD} = \text{Min}, I_{OH} = -1.0 \text{ mA}$                                                            | 2.0   | —                | V       |
| $V_{OL}$                     | Output LOW voltage                            | $V_{DDQ} = 3.3 V, V_{DD} = \text{Max}, I_{OL} = 8.0 \text{ mA}$                                                             | —     | 0.4              | V       |
|                              |                                               | $V_{DDQ} = 2.5 V, V_{DD} = \text{Max}, I_{OL} = 1.0 \text{ mA}$                                                             | —     | 0.4              | V       |
| $V_{IH}$                     | Input HIGH voltage <sup>[9]</sup>             | $V_{DDQ} = 3.3 V$                                                                                                           | 2.0   | $V_{DD} + 0.3 V$ | V       |
|                              |                                               | $V_{DDQ} = 2.5 V$                                                                                                           | 1.7   | $V_{DD} + 0.3 V$ | V       |
| $V_{IL}$                     | Input LOW voltage <sup>[9]</sup>              | $V_{DDQ} = 3.3 V$                                                                                                           | -0.3  | 0.8              | V       |
|                              |                                               | $V_{DDQ} = 2.5 V$                                                                                                           | -0.3  | 0.7              | V       |
| $I_X$                        | Input leakage current except ZZ and MODE      | $GND \leq V_I \leq V_{DDQ}$                                                                                                 | -5    | 5                | $\mu A$ |
|                              | Input current of MODE                         | Input = $V_{SS}$                                                                                                            | -30   | —                | $\mu A$ |
|                              |                                               | Input = $V_{DD}$                                                                                                            | —     | 5                | $\mu A$ |
|                              | Input current of ZZ                           | Input = $V_{SS}$                                                                                                            | -5    | —                | $\mu A$ |
|                              |                                               | Input = $V_{DD}$                                                                                                            | —     | 30               | $\mu A$ |
| $I_{OZ}$                     | Output leakage current                        | $GND \leq V_I \leq V_{DDQ}$ , output disabled                                                                               | -5    | 5                | $\mu A$ |
| $I_{DD}$                     | $V_{DD}$ operating supply current             | $V_{DD} = \text{Max}, I_{OUT} = 0 \text{ mA}, f = f_{MAX} = 1/t_{CYC}$                                                      | —     | 225              | mA      |
| $I_{SB1}$                    | Automatic CE power-down current – TTL inputs  | $V_{DD} = \text{Max}$ , device deselected, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$ , $f = f_{MAX} = 1/t_{CYC}$         | —     | 90               | mA      |
| $I_{SB2}$                    | Automatic CE power-down current – CMOS inputs | $V_{DD} = \text{Max}$ , device deselected, $V_{IN} \leq 0.3 V$ or $V_{IN} \geq V_{DDQ} - 0.3 V$ , $f = 0$                   | —     | 40               | mA      |
| $I_{SB3}$                    | Automatic CE power-down current – CMOS inputs | $V_{DD} = \text{Max}$ , device deselected, $V_{IN} \leq 0.3 V$ or $V_{IN} \geq V_{DDQ} - 0.3 V$ , $f = f_{MAX} = 1/t_{CYC}$ | —     | 75               | mA      |
| $I_{SB4}$                    | Automatic CE power-down current – TTL inputs  | $V_{DD} = \text{Max}$ , device deselected, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$ , $f = 0$                           | —     | 45               | mA      |

### Notes

9. Overshoot:  $V_{IH(AC)} < V_{DD} + 1.5 V$  (Pulse width less than  $t_{CYC}/2$ ), undershoot:  $V_{IL(AC)} > -2 V$  (Pulse width less than  $t_{CYC}/2$ ).

10.  $T_{Power-up}$ : Assumes a linear ramp from 0 V to  $V_{DD(min)}$  within 200 ms. During this time  $V_{IH} < V_{DD}$  and  $V_{DDQ} \leq V_{DD}$ .

## Capacitance

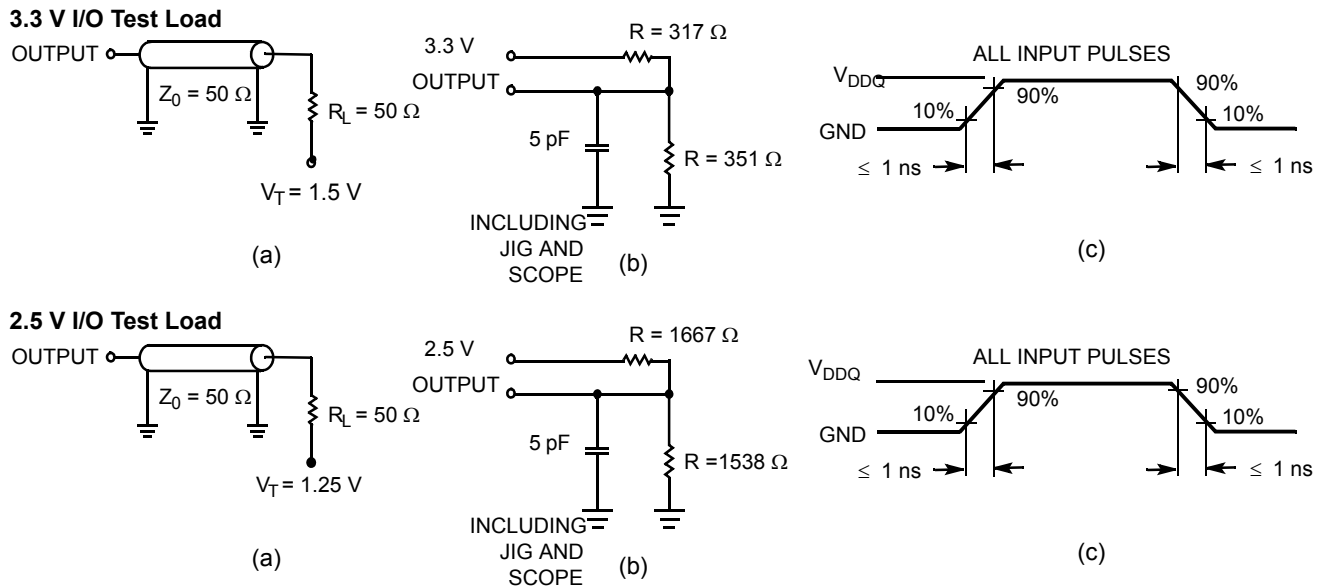
| Parameter <sup>[11]</sup> | Description              | Test Conditions                                                                                                 | 100-pin TQFP Max | Unit |
|---------------------------|--------------------------|-----------------------------------------------------------------------------------------------------------------|------------------|------|
| $C_{IN}$                  | Input capacitance        | $T_A = 25\text{ }^{\circ}\text{C}$ , $f = 1\text{ MHz}$ ,<br>$V_{DD} = 3.3\text{ V}$ , $V_{DDQ} = 3.3\text{ V}$ | 5                | pF   |
| $C_{CLK}$                 | Clock input capacitance  |                                                                                                                 | 5                | pF   |
| $C_{I/O}$                 | Input/Output capacitance |                                                                                                                 | 5                | pF   |

## Thermal Resistance

| Parameter <sup>[11]</sup> | Description                              | Test Conditions                                                                                              | 100-pin TQFP Package | Unit                 |
|---------------------------|------------------------------------------|--------------------------------------------------------------------------------------------------------------|----------------------|----------------------|
| $\Theta_{JA}$             | Thermal resistance (junction to ambient) | Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA/JESD51. | 30.32                | $^{\circ}\text{C/W}$ |
| $\Theta_{JC}$             | Thermal resistance (junction to case)    |                                                                                                              | 6.85                 | $^{\circ}\text{C/W}$ |

## AC Test Loads and Waveforms

Figure 2. AC Test Loads and Waveforms



### Note

11. Tested initially and after any design or process change that may affect these parameters.

## Switching Characteristics

Over the Operating Range

| Parameter <sup>[12, 13]</sup> | Description                                                   | -133 |     | Unit |
|-------------------------------|---------------------------------------------------------------|------|-----|------|
|                               |                                                               | Min  | Max |      |
| $t_{POWER}$                   | $V_{DD}(\text{typical})$ to the first access <sup>[14]</sup>  | 1.0  | –   | ms   |
| <b>Clock</b>                  |                                                               |      |     |      |
| $t_{CYC}$                     | Clock cycle time                                              | 7.5  | –   | ns   |
| $t_{CH}$                      | Clock HIGH                                                    | 3.0  | –   | ns   |
| $t_{CL}$                      | Clock LOW                                                     | 3.0  | –   | ns   |
| <b>Output Times</b>           |                                                               |      |     |      |
| $t_{CO}$                      | Data output valid after CLK rise                              | –    | 4.0 | ns   |
| $t_{DOH}$                     | Data output hold after CLK rise                               | 1.5  | –   | ns   |
| $t_{CLZ}$                     | Clock to low Z <sup>[15, 16, 17]</sup>                        | 0    | –   | ns   |
| $t_{CHZ}$                     | Clock to high Z <sup>[15, 16, 17]</sup>                       | –    | 4.0 | ns   |
| $t_{OE\overline{V}}$          | $\overline{OE}$ LOW to output valid                           | –    | 4.0 | ns   |
| $t_{OE\overline{L}Z}$         | $\overline{OE}$ LOW to output low Z <sup>[15, 16, 17]</sup>   | 0    | –   | ns   |
| $t_{OE\overline{H}Z}$         | $\overline{OE}$ HIGH to output high Z <sup>[15, 16, 17]</sup> | –    | 4.0 | ns   |
| <b>Setup Times</b>            |                                                               |      |     |      |
| $t_{AS}$                      | Address setup before CLK rise                                 | 1.5  | –   | ns   |
| $t_{ADS}$                     | ADSC, ADSP setup before CLK rise                              | 1.5  | –   | ns   |
| $t_{ADVS}$                    | ADV setup before CLK rise                                     | 1.5  | –   | ns   |
| $t_{WES}$                     | GW, BWE, $\overline{BW}_X$ setup before CLK rise              | 1.5  | –   | ns   |
| $t_{DS}$                      | Data input setup before CLK rise                              | 1.5  | –   | ns   |
| $t_{CES}$                     | Chip enable setup before CLK rise                             | 1.5  | –   | ns   |
| <b>Hold Times</b>             |                                                               |      |     |      |
| $t_{AH}$                      | Address hold after CLK rise                                   | 0.5  | –   | ns   |
| $t_{ADH}$                     | ADSP, ADSC hold after CLK rise                                | 0.5  | –   | ns   |
| $t_{ADVH}$                    | ADV hold after CLK rise                                       | 0.5  | –   | ns   |
| $t_{WEH}$                     | GW, BWE, $\overline{BW}_X$ hold after CLK rise                | 0.5  | –   | ns   |
| $t_{DH}$                      | Data input hold after CLK rise                                | 0.5  | –   | ns   |
| $t_{CEH}$                     | Chip enable hold after CLK rise                               | 0.5  | –   | ns   |

### Notes

12. Timing reference level is 1.5 V when  $V_{DDQ} = 3.3$  V and is 1.25 V when  $V_{DDQ} = 2.5$  V.

13. Test conditions shown in (a) of [Figure 2 on page 11](#) unless otherwise noted.

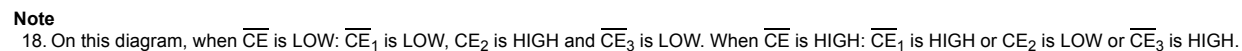
14. This part has a voltage regulator internally;  $t_{POWER}$  is the time that the power needs to be supplied above  $V_{DD(\text{minimum})}$  initially before a read or write operation can be initiated.

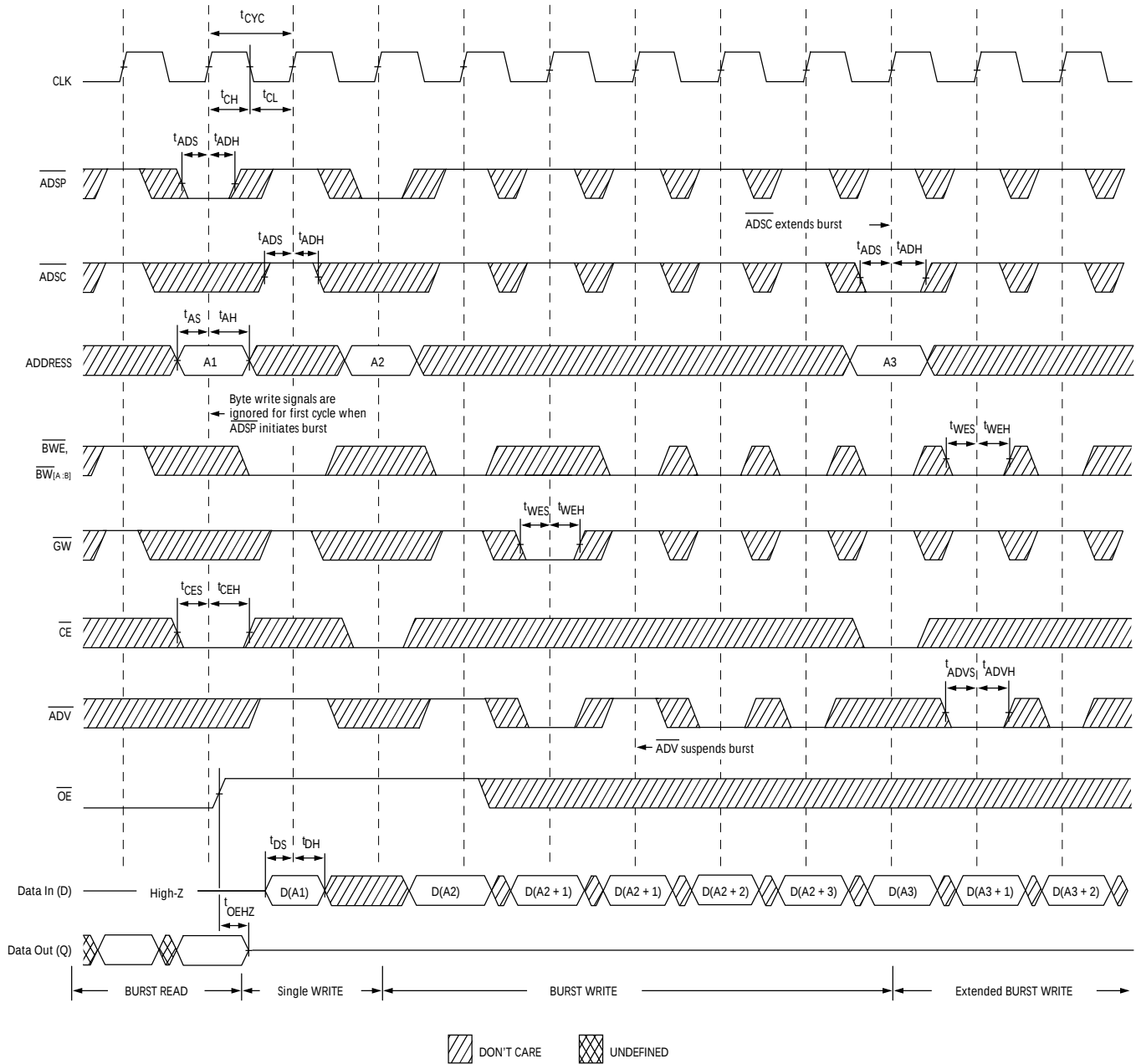
15.  $t_{CHZ}$ ,  $t_{CLZ}$ ,  $t_{OE\overline{L}Z}$ , and  $t_{OE\overline{H}Z}$  are specified with AC test conditions shown in part (b) of [Figure 2 on page 11](#). Transition is measured  $\pm 200$  mV from steady-state voltage.

16. At any given voltage and temperature,  $t_{OE\overline{H}Z}$  is less than  $t_{OE\overline{L}Z}$  and  $t_{CHZ}$  is less than  $t_{CLZ}$  to eliminate bus contention between SRAMs when sharing the same data bus. These specifications do not imply a bus contention condition, but reflect parameters guaranteed over worst case user conditions. Device is designed to achieve high Z prior to low Z under the same system conditions.

17. This parameter is sampled and not 100% tested.

**Figure 3. Read Timing** <sup>[18]</sup>

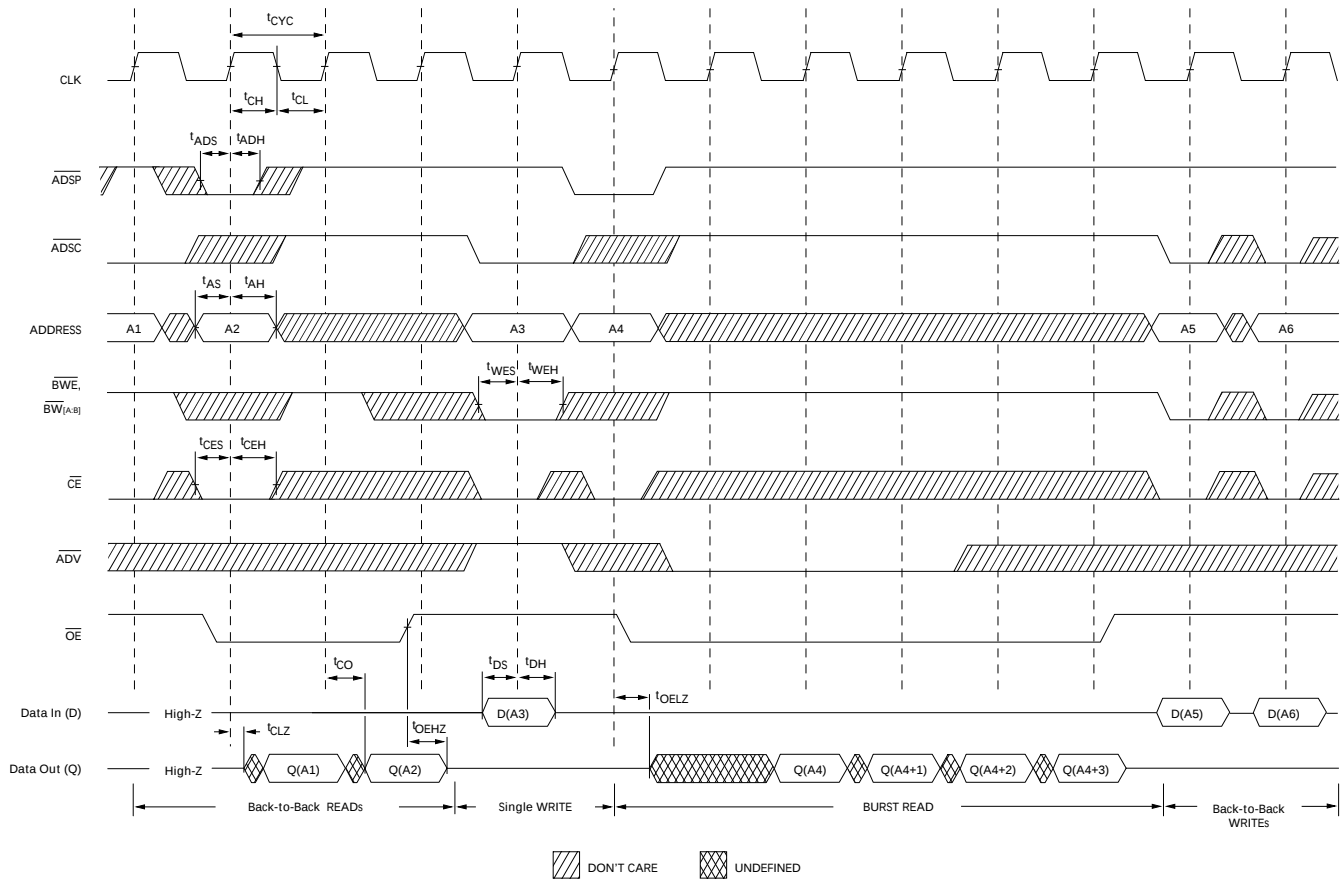


**Switching Waveforms (continued)**
**Figure 4. Write Timing** <sup>[19, 20]</sup>

**Notes**

19. On this diagram, when  $\overline{CE}$  is LOW:  $\overline{CE}_1$  is LOW,  $CE_2$  is HIGH and  $\overline{CE}_3$  is LOW. When  $\overline{CE}$  is HIGH:  $\overline{CE}_1$  is HIGH or  $CE_2$  is LOW or  $\overline{CE}_3$  is HIGH.
20. Full width write can be initiated by either  $\overline{GW}$  LOW; or by  $\overline{GW}$  HIGH,  $\overline{BWE}$  LOW and  $\overline{BW}_{[A:B]}$  LOW.

## Switching Waveforms (continued)

**Figure 5. Read/Write Timing** [21, 22, 23]

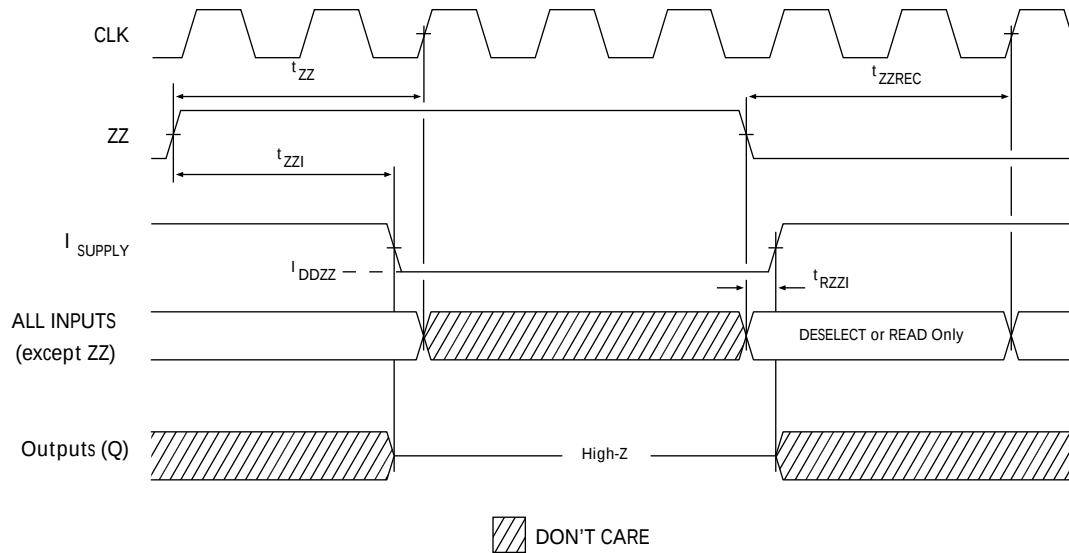


### Notes

21. On this diagram, when  $\overline{CE}$  is LOW:  $\overline{CE}_1$  is LOW,  $\overline{CE}_2$  is HIGH and  $\overline{CE}_3$  is LOW. When  $\overline{CE}$  is HIGH:  $\overline{CE}_1$  is HIGH or  $\overline{CE}_2$  is LOW or  $\overline{CE}_3$  is HIGH.  
 22. The data bus (Q) remains in high Z following a WRITE cycle, unless a new read access is initiated by ADSP or ADSC.  
 23. GW is HIGH.

## Switching Waveforms *(continued)*

**Figure 6. ZZ Mode Timing** [24, 25]



### Notes

24. Device must be deselected when entering ZZ mode. See truth table for all possible signal conditions to deselect the device.
25. DQs are in high Z when exiting ZZ sleep mode.

## Ordering Information

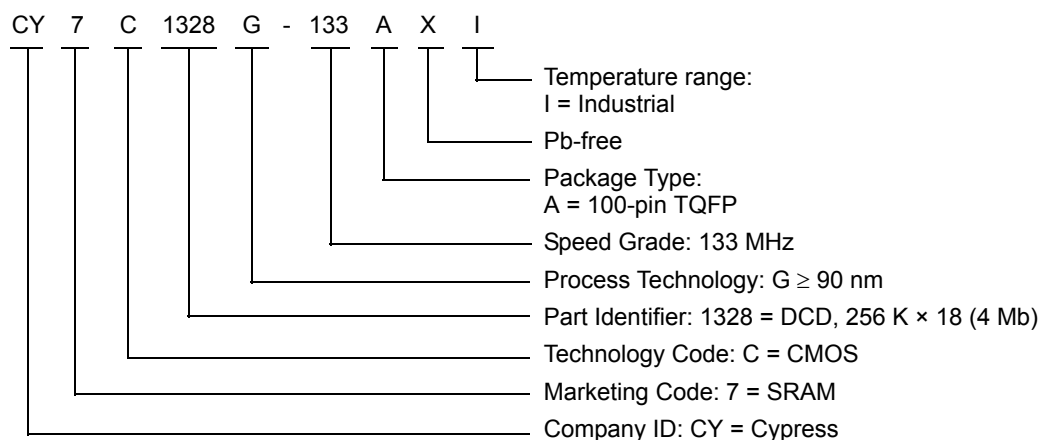
Cypress offers other versions of this type of product in many different configurations and features. The following table contains only the list of parts that are currently available.

For a complete listing of all options, visit the Cypress website at [www.cypress.com](http://www.cypress.com) and refer to the product summary page at <http://www.cypress.com/products> or contact your local sales representative.

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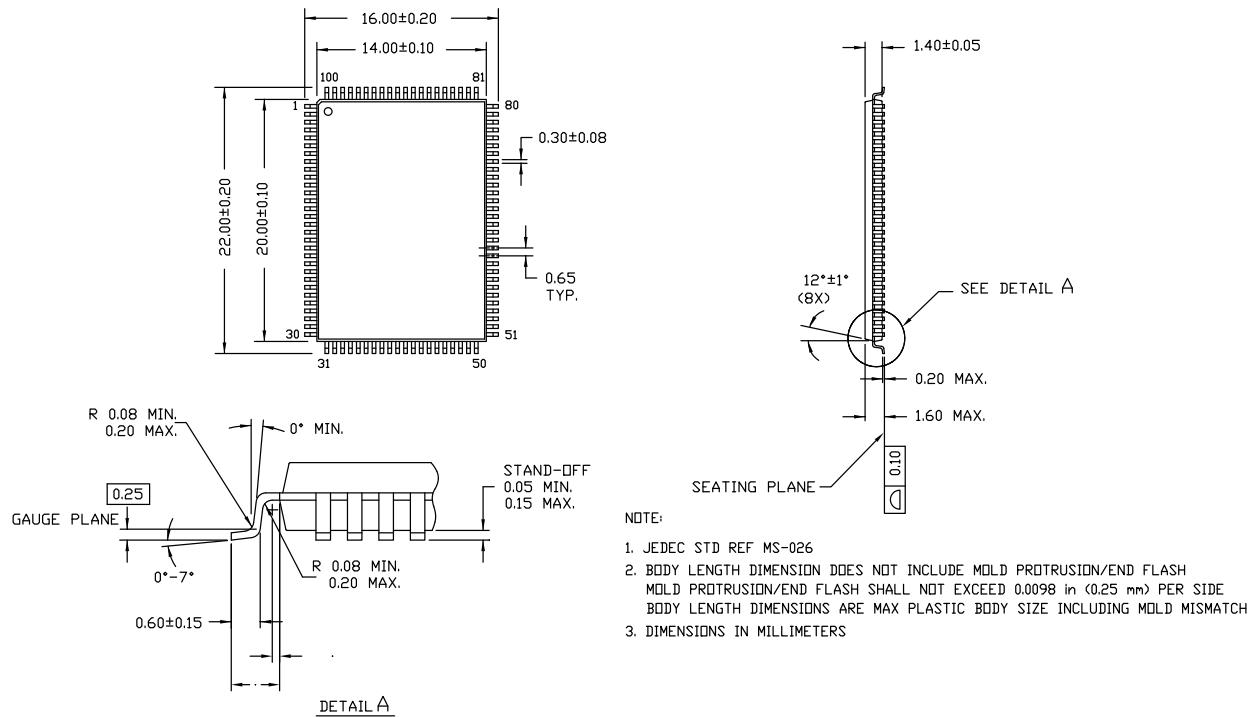
| Speed (MHz) | Ordering Code    | Package Diagram | Package Type                            | Operating Range |
|-------------|------------------|-----------------|-----------------------------------------|-----------------|
| 133         | CY7C1328G-133AXI | 51-85050        | 100-pin TQFP (14 × 20 × 1.4 mm) Pb-free | Industrial      |

## Ordering Code Definitions



## Package Diagram

**Figure 7. 100-pin TQFP (14 × 20 × 1.4 mm) A100RA Package Outline, 51-85050**



51-85050 \*E

## Acronyms

| Acronym                | Description                                |
|------------------------|--------------------------------------------|
| $\overline{\text{CE}}$ | Chip Enable                                |
| CMOS                   | Complementary Metal Oxide Semiconductor    |
| EIA                    | Electronic Industries Alliance             |
| I/O                    | Input/Output                               |
| JEDEC                  | Joint Electron Devices Engineering Council |
| $\overline{\text{OE}}$ | Output Enable                              |
| SRAM                   | Static Random Access Memory                |
| TQFP                   | Thin Quad Flat Pack                        |
| TTL                    | Transistor-Transistor Logic                |

## Document Conventions

### Units of Measure

| Symbol             | Unit of Measure |
|--------------------|-----------------|
| $^{\circ}\text{C}$ | degree Celsius  |
| MHz                | megahertz       |
| $\mu\text{A}$      | microampere     |
| mA                 | milliampere     |
| mm                 | millimeter      |
| ms                 | millisecond     |
| mV                 | millivolt       |
| nm                 | nanometer       |
| ns                 | nanosecond      |
| $\Omega$           | ohm             |
| %                  | percent         |
| pF                 | picofarad       |
| V                  | volt            |
| W                  | watt            |

## Errata

This section describes the Ram9 Sync ZZ pin issue. Details include trigger conditions, the devices affected, proposed workaround and silicon revision applicability. Please contact your local Cypress sales representative if you have further questions.

### Part Numbers Affected

| Density & Revision                    | Package Type | Operating Range |
|---------------------------------------|--------------|-----------------|
| 4Mb-Ram9 Synchronous SRAMs: CY7C132*G | 100-pin TQFP | Industrial      |

### Product Status

All of the devices in the Ram9 4Mb Sync family are qualified and available in production quantities.

### Ram9 Sync ZZ Pin Issues Errata Summary

The following table defines the errata applicable to available Ram9 4Mb Sync family devices.

| Item | Issues | Description                                                                                                                                                                                                                                                    | Device         | Fix Status                                                           |
|------|--------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------|----------------------------------------------------------------------|
| 1.   | ZZ Pin | When asserted HIGH, the ZZ pin places device in a "sleep" condition with data integrity preserved. The ZZ pin currently does not have an internal pull-down resistor and hence cannot be left floating externally by the user during normal mode of operation. | 4M-Ram9 (90nm) | For the 4M Ram9 (90 nm) devices, there is no plan to fix this issue. |

#### 1. ZZ Pin Issue

##### ■ PROBLEM DEFINITION

The problem occurs only when the device is operated in the normal mode with ZZ pin left floating. The ZZ pin on the SRAM device does not have an internal pull-down resistor. Switching noise in the system may cause the SRAM to recognize a HIGH on the ZZ input, which may cause the SRAM to enter sleep mode. This could result in incorrect or undesirable operation of the SRAM.

##### ■ TRIGGER CONDITIONS

Device operated with ZZ pin left floating.

##### ■ SCOPE OF IMPACT

When the ZZ pin is left floating, the device delivers incorrect data.

##### ■ WORKAROUND

Tie the ZZ pin externally to ground.

##### ■ FIX STATUS

For the 4M Ram9 (90 nm) devices, there is no plan to fix this issue.

## Document History Page

| Document Title: CY7C1328G, 4-Mbit (256 K × 18) Pipelined DCD Sync SRAM<br>Document Number: 38-05523 |         |            |                 |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|-----------------------------------------------------------------------------------------------------|---------|------------|-----------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Rev.                                                                                                | ECN No. | Issue Date | Orig. of Change | Description of Change                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| **                                                                                                  | 224371  | See ECN    | RKF             | New data sheet.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| *A                                                                                                  | 288909  | See ECN    | VBL             | Updated <a href="#">Ordering Information</a> (Changed TQFP package to Pb-free TQFP package).                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| *B                                                                                                  | 333625  | See ECN    | SYT             | Updated <a href="#">Pin Configurations</a> (Modified Address Expansion balls in the pinouts for 100-pin TQFP Package as per JEDEC standards).<br>Updated <a href="#">Pin Definitions</a> .<br>Updated <a href="#">Electrical Characteristics</a> (Updated test conditions for $V_{OL}$ and $V_{OH}$ parameters).<br>Updated <a href="#">Thermal Resistance</a> (Replaced TBD's for $\Theta_{JA}$ and $\Theta_{JC}$ to their respective values).<br>Updated <a href="#">Ordering Information</a> (By shading and unshading MPNs as per availability).                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| *C                                                                                                  | 419264  | See ECN    | R XU            | Changed status from Preliminary to Final.<br>Changed address of Cypress Semiconductor Corporation from "3901 North First Street" to "198 Champion Court".<br>Updated <a href="#">Features</a> (Removed 133 MHz frequency related information, replaced 166 MHz with 167 MHz).<br>Updated <a href="#">Selection Guide</a> (Removed 133 MHz frequency related information, replaced 166 MHz with 167 MHz).<br>Updated <a href="#">Electrical Characteristics</a> (Updated Note 10 (Changed test condition from $V_{IH} \leq V_{DD}$ to $V_{IH} < V_{DD}$ ), changed the test condition for $V_{OL}$ parameter from $V_{DD} = \text{Min.}$ to $V_{DD} = \text{Max.}$ , changed "Input Load Current except ZZ and MODE" to "Input Leakage Current except ZZ and MODE", removed 133 MHz frequency related information, replaced 166 MHz with 167 MHz).<br>Updated <a href="#">Switching Characteristics</a> (Removed 133 MHz frequency related information, replaced 166 MHz with 167 MHz).<br>Updated <a href="#">Ordering Information</a> (Updated part numbers, replaced Package Name column with Package Diagram in the Ordering Information table).<br>Updated <a href="#">Package Diagram</a> . |
| *D                                                                                                  | 430373  | See ECN    | NXR             | Updated <a href="#">Features</a> (Included 133 MHz frequency related information).<br>Updated <a href="#">Selection Guide</a> (Included 133 MHz frequency related information).<br>Updated <a href="#">Electrical Characteristics</a> (Included 133 MHz frequency related information).<br>Updated <a href="#">Switching Characteristics</a> (Included 133 MHz frequency related information).<br>Updated <a href="#">Ordering Information</a> (Updated part numbers).                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| *E                                                                                                  | 480368  | See ECN    | VKN             | Updated <a href="#">Maximum Ratings</a> (Added the Maximum Rating for Supply Voltage on $V_{DDQ}$ Relative to GND).<br>Updated <a href="#">Ordering Information</a> (Updated part numbers).                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| *F                                                                                                  | 2896584 | 03/20/2010 | NJY             | Updated <a href="#">Ordering Information</a> (Removed obsolete part numbers).<br>Updated <a href="#">Package Diagram</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| *G                                                                                                  | 3045943 | 10/03/2010 | NJY             | Added <a href="#">Ordering Code Definitions</a> .<br>Added <a href="#">Acronyms</a> and <a href="#">Units of Measure</a> .<br>Minor edits.<br>Updated to new template.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| *H                                                                                                  | 3353361 | 08/24/2011 | PRIT            | Updated <a href="#">Functional Description</a> (Updated Note as "For best practices recommendations, refer to <a href="#">SRAM System Design Guidelines</a> ." and referred the note in same place in this section).<br>Updated <a href="#">Package Diagram</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |

**Document History Page** *(continued)*

| Document Title: CY7C1328G, 4-Mbit (256 K × 18) Pipelined DCD Sync SRAM<br>Document Number: 38-05523 |         |            |                 |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
|-----------------------------------------------------------------------------------------------------|---------|------------|-----------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Rev.                                                                                                | ECN No. | Issue Date | Orig. of Change | Description of Change                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| *I                                                                                                  | 3589101 | 04/17/2012 | NJY / PRIT      | Updated <a href="#">Features</a> (Removed 250 MHz, 200 MHz and 167 MHz frequencies related information).<br>Updated <a href="#">Functional Description</a> (Removed the Note “For best practices recommendations, refer to <a href="#">SRAM System Design Guidelines</a> .”).<br>Updated <a href="#">Selection Guide</a> (Removed 250 MHz, 200 MHz and 167 MHz frequencies related information).<br>Updated <a href="#">Operating Range</a> (Removed Commercial Temperature Range).<br>Updated <a href="#">Electrical Characteristics</a> (Removed 250 MHz, 200 MHz and 167 MHz frequencies related information).<br>Updated <a href="#">Switching Characteristics</a> (Removed 250 MHz, 200 MHz and 167 MHz frequencies related information). |
| *J                                                                                                  | 3754982 | 09/25/2012 | PRIT            | No technical updates.<br>Completing Sunset Review.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| *K                                                                                                  | 3990978 | 05/04/2013 | PRIT            | Added <a href="#">Errata</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
| *L                                                                                                  | 4039556 | 06/25/2013 | PRIT            | Added Errata Footnotes.<br>Updated to new template.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| *M                                                                                                  | 4150716 | 10/08/2013 | PRIT            | Updated <a href="#">Errata</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| *N                                                                                                  | 4539104 | 10/15/2014 | PRIT            | Updated <a href="#">Package Diagram</a> :<br>spec 51-85050 – Changed revision from *D to *E.<br>Completing Sunset Review.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| *O                                                                                                  | 4571917 | 11/18/2014 | PRIT            | Added related documentation hyperlink in page 1.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |

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